## PC925LONSZOF Series

## Description

PC925LONSZOF Series contains a LED optically cou－ pled to an OPIC chip．
It is packaged in a 8 pin DIP，available in SMT gullwing lead form option．

Peak output current is 2.5 A ，Input－output isolation voltage（rms）is 5 kV and High speed response（ $\mathrm{t}_{\text {PHL，}} \mathrm{t}_{\text {PLH }}$ ： MAX．0．5 s ）．

## ■ Features

1．8 pin DIP package
2．Double transfer mold package
（Ideal for Flow Soldering）
3．Built－in direct drive circuit for MOSFET／IGBT drive （ $\mathrm{l}_{\text {（peak）}}: 2.5 \mathrm{~A}$ ）
4．High speed response（tphL， $\mathrm{t}_{\mathrm{PLH}}:$ MAX． $0.5 \mu \mathrm{~s}$ ）
5 ．Wide operating supply voltage range
（ $\mathrm{V}_{\mathrm{CC}}=15$ to 30 V ）
6．High noise immunity due to high instantaneous com－ mon mode rejection voltage（ $\mathrm{CM}_{\mathrm{H}}$ ：MIN．$-15 \mathrm{kV} / \mu \mathrm{s}$ ， $\mathrm{CM}_{\mathrm{L}}: \mathrm{MIN} .15 \mathrm{kV} / \mathrm{\mu s}$ ）
7．Long creepage distance type（wide lead－form type only ：MIN．8mm）
8．High isolation voltage between input and output （ $\mathrm{V}_{\text {iso（rms）}}$ ： 5 kV ）
9．Lead－free and RoHS directive compliant

## High Speed，2．5A Output， Gate Drive DIP 8 pin ＊OPIC Photocoupler



## Agency approvals／Compliance

1．Recognized by UL1577（Double protection isolation）， file No．E64380（as model No．PC925L）
2．Package resin：UL flammability grade（ $94 \mathrm{~V}-0$ ）
3．Compliant with RoHS directive（2002／95／EC）
4．Content status of six substances specified in
＂Management Methods for Control of Pollution Caused by Electronic Information Products Regulation＂ （Chinese：电子信息产品污染控制管理办法） （popular name ：China RoHS） ；refer to page 16

## Applications

1．IGBT／MOSFET gate drive for inverter control
＊＂OPIC＂（Optical IC）is a trademark of the SHARP Corporation．An OPIC consists of a light－detecting element and a signal－pro－ cessing circuit integrated onto a single chip．

Internal Connection Diagram

(1) N.C.
(5) GND
(2) Anode
(3) Cathode
(6) $\mathrm{V}_{\mathrm{O}}$
(7) $V_{0}$
(4) N.C.
(8) $\mathrm{V}_{\mathrm{CC}}$

## Truth table

| Input | $\mathrm{V}_{\mathrm{O}}$ Terminal output | Tr1 | $\operatorname{Tr} 2$ |
| :---: | :---: | :---: | :---: |
| ON | High level | ON | OFF |
| OFF | Low level | OFF | ON |

## Outline Dimensions

(Unit : mm)

## 1. Through-Hole [ex. PC925LONSZOF]


2. SMT Gullwing Lead-Form [ex. PC925LONIPOF]


Product mass : approx. 0.51 g
(Unit : mm)

## 3. Wide SMT Gullwing Lead-Form

 [ex. PC925LONUP0F]

Product mass : approx. 0.55 g
Plating material : Pd (Au flash)

Date code (3 digit)

| 1st digit |  |  |  | 2nd digit |  | 3rd digit |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Year of production |  |  |  | Month of production |  | Week of production |  |
| A.D. | Mark | A.D. | Mark | Month | Mark | Week | Mark |
| 1990 | A | 2002 | P | January | 1 | 1st | 1 |
| 1991 | B | 2003 | R | February | 2 | 2nd | 2 |
| 1992 | C | 2004 | S | March | 3 | 3rd | 3 |
| 1993 | D | 2005 | T | April | 4 | 4th | 4 |
| 1994 | E | 2006 | U | May | 5 | 5, 6th | 5 |
| 1995 | F | 2007 | V | June | 6 |  |  |
| 1996 | H | 2008 | W | July | 7 |  |  |
| 1997 | J | 2009 | X | August | 8 |  |  |
| 1998 | K | 2010 | A | September | 9 |  |  |
| 1999 | L | 2011 | B | October | O |  |  |
| 2000 | M | 2012 | C | November | N |  |  |
| 2001 | N | : | : | December | D |  |  |

repeats in a 20 year cycle

Factory identification mark

| Factory identification Mark | Country of origin |
| :---: | :---: |
| no mark | Japan |
| $\square$ | Indonesia |
| $\Delta$ or $\square$ | China |
| $\square$ |  |

* This factory marking is for identification purpose only.

Please contact the local SHARP sales representative to see the actural status of the production.

Rank mark
With or without.

| $\square$ Absolute Maximum Ratings |  |  |  | $\left(\mathrm{T}_{\mathrm{a}}=25^{\circ} \mathrm{C}\right)$ |
| :---: | :---: | :---: | :---: | :---: |
| Parameter |  | Symbol | Rating | Unit |
| Input | ${ }^{* 1}$ Forward current | $\mathrm{I}_{\mathrm{F}}$ | 25 | mA |
|  | Reverse voltage | $\mathrm{V}_{\mathrm{R}}$ | 5 | V |
|  | ${ }^{* 2}$ Peak forward current | $\mathrm{I}_{\mathrm{FM}}$ | 1 | A |
| Output | Supply voltage | $\mathrm{V}_{\mathrm{CC}}$ | 35 | V |
|  | ${ }^{* 3}$ Peak output current | $\mathrm{I}_{\text {O(PEAK) }}$ | 2.5 | A |
|  | Output voltage | $\mathrm{V}_{0}$ | $\mathrm{V}_{\text {CC }}$ | V |
|  | ${ }^{*} 4$ Output power dissipation | $\mathrm{P}_{\mathrm{O}}$ | 250 | mW |
| ${ }^{* 5}$ Total power dissipation |  | $\mathrm{P}_{\text {tot }}$ | 295 | mW |
| ${ }^{* 6}$ Isolation voltage |  | $\mathrm{V}_{\text {iso(rms) }}$ | 5 | kV |
| Operating temperature |  | $\mathrm{T}_{\text {opr }}$ | -40 to +100 | ${ }^{\circ} \mathrm{C}$ |
| Storage temperature |  | $\mathrm{T}_{\text {stg }}$ | -55 to +125 | ${ }^{\circ} \mathrm{C}$ |
| ${ }^{* 7}$ Soldering temperature |  | $\mathrm{T}_{\text {sol }}$ | 270 | ${ }^{\circ} \mathrm{C}$ |

*1 When ambient temperature goes above $70^{\circ} \mathrm{C}$, the power dissipation goes down at $0.3 \mathrm{~mA} /{ }^{\circ} \mathrm{C}$ (Refer to Fig.10).
*2 Pulse width $\leq 1 \mu \mathrm{~s}, 300 \mathrm{pps}$
*3 Pulse width $\leq 10 \mu \mathrm{~s}$, Duty ratio : 0.002
*4 When ambient temperature goes above $70^{\circ} \mathrm{C}$, the power dissipation goes down at $4.8 \mathrm{~mA} /{ }^{\circ} \mathrm{C}$ (Refer to Fig.11).
*5 When ambient temperature goes above $70^{\circ} \mathrm{C}$, the power dissipation goes down at $5.4 \mathrm{~mA} /{ }^{\circ} \mathrm{C}$ (Refer to Fig.12).
*6 AC for $1 \mathrm{~min}, 40$ to $60 \% \mathrm{RH}, \mathrm{f}=60 \mathrm{~Hz}$
*7 For 10s

Electro-optical Characteristics*8
(Unless otherwise specified : $\mathrm{T}_{\mathrm{a}}=-+40$ to $+100^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{F}(\mathrm{ON})}=7$ to $16 \mathrm{~mA}, \mathrm{~V}_{\mathrm{CC}}=15$ to $30 \mathrm{~V}, \mathrm{~V}_{\mathrm{F}(\mathrm{OFF})}=-3 \mathrm{~V}$ to 0.8 V )

| Parameter |  | Symbol | Condition | MIN. | ${ }^{* 13} \mathrm{TYP}$. | MAX. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | Forward voltage | $\mathrm{V}_{\mathrm{F}}$ | $\mathrm{I}_{\mathrm{F}}=10 \mathrm{~mA}$ | 1.2 | - | 1.8 | V |
|  | Reverse current | $\mathrm{I}_{\mathrm{R}}$ | $\mathrm{V}_{\mathrm{R}}=5 \mathrm{~V}$ | - | - | 10 | $\mu \mathrm{A}$ |
|  | Terminal capacitance | $\mathrm{C}_{\mathrm{t}}$ | $\mathrm{T}_{\mathrm{a}}=25^{\circ} \mathrm{C}, \mathrm{V}=0, \mathrm{f}=1 \mathrm{MHz}$ | - | 60 | 150 | pF |
| High level output current |  | $\mathrm{I}_{\mathrm{OH}}$ | ${ }^{* 8} \mathrm{~V}_{\mathrm{O}}=\left(\mathrm{V}_{\mathrm{CC}}-4 \mathrm{~V}\right), \mathrm{I}_{\mathrm{F}(\mathrm{ON})}$ | 0.5 | 1.5 | - | A |
|  |  | ${ }^{* 9} \mathrm{~V}_{\mathrm{O}}=\left(\mathrm{V}_{\mathrm{CC}}-15 \mathrm{~V}\right), \mathrm{I}_{\mathrm{F}(\mathrm{ON})}$ | 2 | - | - | A |
| $\begin{aligned} & \bar{Z} \\ & 0 \\ & 0 \end{aligned}$ | Low level output current |  | $\mathrm{I}_{\text {OL }}$ | ${ }^{* 8} \mathrm{~V}_{\mathrm{O}}=2.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{F}(\text { OFF) }}$ | 0.5 | 2.0 | - | A |
|  |  | ${ }^{* 9} \mathrm{~V}_{\mathrm{O}}=15 \mathrm{~V}, \mathrm{~V}_{\mathrm{F}(\mathrm{OFF})}$ |  | 2 | - | - | A |
|  | High level output voltage | $\mathrm{V}_{\mathrm{OH}}$ | $\mathrm{I}_{\mathrm{O}}=-0.1 \mathrm{~A}, \mathrm{I}_{\mathrm{F}(\mathrm{ON})}$ | $\mathrm{V}_{\mathrm{CC}}-4$ | $\mathrm{V}_{\mathrm{CC}-3}$ | - | V |
|  | Low level output voltage | $\mathrm{V}_{\text {OL }}$ | $\mathrm{I}_{\mathrm{O}}=0.1 \mathrm{~A}, \mathrm{~V}_{\mathrm{F}(\text { OFF) }}$ | - | 0.1 | 0.5 | V |
|  | ${ }^{* 10}$ High level supply current | $\mathrm{I}_{\text {CCH }}$ | $\mathrm{I}_{\mathrm{F}(\mathrm{ON})}$ | - | 2.5 | 5 | mA |
|  | ${ }^{* 10}$ Low level supply current | $\mathrm{I}_{\text {CCL }}$ | $\mathrm{V}_{\mathrm{F} \text { (OFF) }}$ | - | 2.5 | 5 | mA |
|  | UVLO threshold | $\mathrm{V}_{\mathrm{UVLO}+}$ | $\mathrm{V}_{\mathrm{O}}>5 \mathrm{~V}, \mathrm{I}_{\mathrm{F}}=10 \mathrm{~mA}$ | 11 | 12.3 | 13.5 | V |
|  |  | $\mathrm{V}_{\text {UVLO- }}$ |  | 9.5 | 10.7 | 12 | V |
|  | UVLO Hysteresis | $\mathrm{UVLO}_{\mathrm{HYS}}$ |  | - | 1.6 | - | V |
| 烒 | *11"Low $\rightarrow$ High" threshold input current | $\mathrm{I}_{\text {FLH }}$ | $\mathrm{V}_{\mathrm{O}}>5 \mathrm{~V}, \mathrm{I}_{\mathrm{O}}=0$ | - | - | 5 | mA |
|  | Isolation resistance | $\mathrm{R}_{\text {ISO }}$ | $\mathrm{T}_{\mathrm{a}}=25^{\circ} \mathrm{C}, \mathrm{DC}=500 \mathrm{~V}, 40$ to $60 \% \mathrm{RH}$ | $5 \times 10^{10}$ | $10^{11}$ | - | $\Omega$ |
|  | "Low $\rightarrow$ High" propagation time | $\mathrm{t}_{\text {PLH }}$ | $\begin{gathered} \mathrm{R}_{\mathrm{G}}=10 \Omega, \mathrm{C}_{\mathrm{G}}=10 \mathrm{nF}, \\ \mathrm{f}=10 \mathrm{kHz}, \text { Duty ratio } 50 \% \end{gathered}$ | 0.1 | 0.3 | 0.5 | $\mu \mathrm{s}$ |
|  | "High $\rightarrow$ Low" propagation time | $\mathrm{t}_{\text {PHL }}$ |  | 0.1 | 0.3 | 0.5 | $\mu \mathrm{s}$ |
|  | . ${ }^{* 12}$ Distortion of pulse width | $\Delta \mathrm{t}_{\mathrm{W}}$ |  | - | - | 0.3 | $\mu \mathrm{s}$ |
|  | o Propagation delay skew | $\mathrm{t}_{\text {PSK }}$ |  | -0.35 | - | 0.35 | $\mu \mathrm{s}$ |
|  | O Rise time | $\mathrm{t}_{\mathrm{r}}$ |  | - | 0.1 | - | $\mu \mathrm{s}$ |
|  | \% Fall time | $\mathrm{t}_{\mathrm{f}}$ |  | - | 0.1 | - | $\mu \mathrm{s}$ |
|  | UVLO Turn on delay | $\mathrm{t}_{\text {UVLO ON }}$ | $\mathrm{V}_{\mathrm{O}}>5 \mathrm{~V}, \mathrm{I}_{\mathrm{F}}=10 \mathrm{~mA}$ | - | 0.8 | - | $\mu \mathrm{s}$ |
|  | UVLO Turn off delay | $\mathrm{t}_{\text {UVLO OFF }}$ | $\mathrm{V}_{\mathrm{O}}>5 \mathrm{~V}, \mathrm{I}_{\mathrm{F}}=10 \mathrm{~mA}$ | - | 0.6 | - | $\mu \mathrm{s}$ |
|  | Instantaneous common mode rejection voltage (High level output) | $\mathrm{ICM}_{\mathrm{H}} \mathrm{l}$ | $\begin{gathered} \mathrm{T}_{\mathrm{a}}=25^{\circ} \mathrm{C}, \mathrm{~V}_{\mathrm{CM}}=1.5 \mathrm{kV}(\mathrm{p}-\mathrm{p}), \\ \mathrm{I}_{\mathrm{F}}=10 \text { to } 16 \mathrm{~mA}, \mathrm{~V}_{\mathrm{CC}}=30 \mathrm{~V}, \mathrm{~V}_{\mathrm{OH}}>15 \mathrm{~V} \\ \hline \end{gathered}$ | 15 | - | - | kV/ $\mu \mathrm{s}$ |
|  | Instantaneous common mode rejection voltage (Low level output) | $\mathrm{ICM}_{\mathrm{L}} \mathrm{l}$ | $\begin{gathered} \mathrm{T}_{\mathrm{a}}=25^{\circ} \mathrm{C}, \mathrm{~V}_{\mathrm{CM}}=1.5 \mathrm{kV}(\mathrm{p}-\mathrm{p}), \\ \mathrm{V}_{\mathrm{F}}=0, \mathrm{~V}_{\mathrm{CC}}=30 \mathrm{~V}, \mathrm{~V}_{\mathrm{OL}}<1 \mathrm{~V} \end{gathered}$ | 15 | - | - | kV/ $\mu \mathrm{s}$ |

*7 It shall connect a by-pass capacitor of $0.1 \mu \mathrm{~F}$ or more between $\mathrm{V}_{\mathrm{CC}}(\operatorname{Pin} \operatorname{No.} 8)$ and GND (Pin No. 5) near the device, when it measures the transfer characteristics and the output side characteristics.
*8 Pulse width $\leq 50 \mu \mathrm{~s}$, Duty ratio : 0.005
*9 Pulse width $\leq 10 \mu$ s, Duty ratio : 0.002
*10 Output pin is open.

* $11 \mathrm{I}_{\mathrm{FLH}}$ is the value of forward current when output becomes from "L" to " H "
*12 Distortion of pulse width $\Delta t_{\mathrm{W}}=\left|\mathrm{t}_{\mathrm{PHL}}-\mathrm{t}_{\text {PLH }}\right|$
*13 All typical values are at $\mathrm{T}_{\mathrm{a}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{CC}}=30 \mathrm{~V}$

| $\square$ Model Line-up | Through-Hole | SMT Gullwing | Wide SMT Gullwing |  |
| :---: | :---: | :---: | :---: | :---: |
| Lead Form | Sleeve | Taping |  |  |
| Package | 50 pcs/sleeve | 1000 pcs/reel |  |  |
| Model No. | PC925LONSZ0F | PC925LONIP0F | PC925LONUPOF |  |

Fig. 1 Test Circuit for High Level Output Current


Fig. 3 Test Circuit for High Level Output Voltage


Fig. 5 Test Circuit for High Level / Low Level Supply Current


Fig. 2 Test Circuit for Low Level Output Current


Fig. 4 Test Circuit for Low Level Output Voltage


Fig. 6 Test Circuit for UVLO Threshold


Fig. 7 Test Circuit for "Low $\rightarrow$ High" Input Threshold Current


Fig. 8 Test Circuit for Response Time


Fig. 9 Test Circuit for Instantaneous Common Mode Rejection Voltage


Fig. 10 Forward Currenet vs.
Ambient Temperature


Fig. 12 Total Power Dissipation vs. Ambient Temperature


Fig. 14 High Level Output Voltage Drop vs. Ambient Temperature


Fig. 11 Power Dissipation vs. Ambient Temperature


Fig. 13 Forward Current vs. Forward Voltage


Fig. 15 High Level Output Voltage Drop vs. Supply Voltage


Fig. 16 Low Level Output Voltage vs.
Ambient Temperature


Fig. 18 High Level Supply Current vs. Ambient Temperature


Fig. 20 Low Level Supply Current vs. Ambient Temperature


Fig. 17 Low Level Output Voltage vs. Supply Voltage


Fig. 19 High Level Supply Current vs. Supply Voltage


Fig. 21 Low Level Supply Current vs. Supply Voltage


Fig. 22 "Low $\rightarrow$ High" Relative Threshold Input Current vs. Ambient Temperature


Fig. 24 Output Voltage vs. Supply Voltage (UVLO Threshold)


Fig. 26 Propagation Delay Time vs. Ambient Temperature


Fig. 23 "Low $\rightarrow$ High" Relative Threshold Input Current vs. Supply Voltage


Fig. 25 Relative UVLO Threshold vs. Ambient Temperature


Remarks: Please be aware that all data in the graph are just for reference and not for guarantee.

## Design Considerations

## - Recommended Operating Conditions

| Parameter | Symbol | MIN. | MAX. | Unit |
| :--- | :---: | :---: | :---: | :---: |
| Input current $(\mathrm{ON})$ | $\mathrm{I}_{\mathrm{F}}(\mathrm{ON})$ | 7 | 16 | mA |
| Input voltage $(\mathrm{OFF})$ | $\mathrm{V}_{\mathrm{F}}(\mathrm{OFF})$ | -3 | 0.8 | V |
| Supply voltage | $\mathrm{V}_{\mathrm{CC}}$ | 15 | 30 | V |
| Operating temperature | $\mathrm{T}_{\mathrm{opr}}$ | -40 | 100 | ${ }^{\circ} \mathrm{C}$ |

## - Notes about static electricity

Transistor of detector side in bipolar configuration may be damaged by static electricity due to its minute design.
When handling these devices, general countermeasure against static electricity should be taken to avoid breakdown of devices or degradation of characteristics.

## - Design guide

In order to stabilize power supply line, please certainly connect a by-pass capacitor of $0.1 \mu \mathrm{~F}$ or more between $\mathrm{V}_{\mathrm{CC}}$ and GND near the device.

In case that some sudden big noise caused by voltage variation is provided between primary and secondary terminals of photocoupler some current caused by it is floating capacitance may be generated and result in false operation since current may go through LED or current may change. If the photocoupler may be used under the circumstances where noise will be generated we recommend to use the bypass capacitors at the both ends of LED.

The detector which is used in this device, has parasitic diode between each pins and GND.
There are cases that miss operation or destruction possibly may be occurred if electric potential of any pin becomes below GND level even for instant.
Therefore it shall be recommended to design the circuit that electric potential of any pin does not become below GND level.

This product is not designed against irradiation and incorporates non-coherent LED.

## - Degradation

In general, the emission of the LED used in photocouplers will degrade over time.
In the case of long term operation, please take the general LED degradation (50\% degradation over 5 years) into the design consideration.
Please decide the input current which become 2 times of MAX. IFLH.

## Recommended Foot Print (reference)

SMT Gullwing Lead-form

(Unit : mm)
Wide SMT Gullwing Lead-form

in For additional design assistance, please review our corresponding Optoelectronic Application Notes.

## Manufacturing Guidelines

## - Soldering Method

## Reflow Soldering :

Reflow soldering should follow the temperature profile shown below.
Soldering should not exceed the curve of temperature profile and time.
Please don't solder more than twice.


Flow Soldering :
Due to SHARP's double transfer mold construction submersion in flow solder bath is allowed under the below listed guidelines.

Flow soldering should be completed below $270^{\circ} \mathrm{C}$ and within 10 s.
Preheating is within the bounds of 100 to $150^{\circ} \mathrm{C}$ and 30 to 80 s .
Please don't solder more than twice.

## Hand soldering

Hand soldering should be completed within 3 s when the point of solder iron is below $400^{\circ} \mathrm{C}$.
Please don't solder more than twice.

## Other notice

Please test the soldering method in actual condition and make sure the soldering works fine, since the impact on the junction between the device and PCB varies depending on the tooling and soldering conditions.

## Cleaning instructions

## Solvent cleaning ：

Solvent temperature should be $45^{\circ} \mathrm{C}$ or below．Immersion time should be 3 minutes or less．

## Ultrasonic cleaning ：

The impact on the device varies depending on the size of the cleaning bath，ultrasonic output，cleaning time， size of PCB and mounting method of the device．
Therefore，please make sure the device withstands the ultrasonic cleaning in actual conditions in advance of mass production．

## Recommended solvent materials ：

Ethyl alcohol，Methyl alcohol and Isopropyl alcohol
In case the other type of solvent materials are intended to be used，please make sure they work fine in ac－ tual using conditions since some materials may erode the packaging resin．

## －Presence of ODC etc．

This product shall not contain the following materials．
And they are not used in the production process for this product．
Regulation substances：CFCs，Halon，Carbon tetrachloride，1，1，1－Trichloroethane（Methylchloroform）
Specific brominated flame retardants such as the PBB and PBDE are not used in this product at all．
－The RoHS directive（2002／95／EC）
This product complies with the RoHS directive（2002／95／EC）．
Object substances：lead，mercury，cadmium，hexavalent chromium，polybrominated biphenyls（PBB）and polybrominated diphenyl ethers（PBDE）
－Content of six substances specified in＂Management Methods for Control of Pollution Caused by Electronic Information Products Regulation＂（Chinese：电子信息产品污染控制管理办法）

|  | Toxic and hazardous substances |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Category | Lead （Pb） | Mercury （Hg） | $\begin{gathered} \text { Cadmium } \\ \text { (Cd) } \end{gathered}$ | Hexavalent chromium （Cr（VI）） | Polybrominated biphenyls （PBB） | Polybrominated diphenyl ethers （PBDE） |
| Photocoupler | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ |

：indicates that the content of the toxic and hazardous substance in all the homogeneous materials of the part is below the concentration limit requirement as described in SJ／T 11363－2006 standard．

## Package specification

## - Sleeve package

## Package materials

Sleeve : HIPS (with anti-static material)
Stopper: Styrene-Elastomer

## Package method

MAX. 50pcs of products shall be packaged in a sleeve.
Both ends shall be closed by tabbed and tabless stoppers.
The product shall be arranged in the sleeve with its anode mark on the tabless stopper side.
MAX. 20 sleeves in one case.
Sleeve outline dimensions


## Tape and Reel package

## 1. SMT Gullwing Lead-Form

Package materials
Carrier tape : A-PET (with anti-static material)
Cover tape : PET (three layer system)
Reel: PS
Carrier tape structure and Dimensions


Dimensions List
(Unit : mm)

| A | B | C | D | E | F | G |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $16.0^{ \pm 0.3}$ | $7.5^{ \pm 0.1}$ | $1.75^{ \pm 0.10}$ | $12.0^{ \pm 0.1}$ | $2.0^{ \pm 0.1}$ | $4.0^{ \pm 0.1}$ | $\phi 1.5_{-0.1}^{+0.1}$ |
| H | I | J | K |  |  |  |
| $10.4^{ \pm 0.1}$ | $0.40^{ \pm 0.05}$ | $4.2^{ \pm 0.1}$ | $10.2^{ \pm 0.1}$ |  |  |  |

Reel structure and Dimensions


| Dimensions List |  | (Unit : mm) |  |
| :---: | :---: | :---: | :---: |
| a | b | c | d |
| $\phi 330$ | $17.5^{ \pm 1.5}$ | $\phi 100^{ \pm 1}$ | $\phi 13.0^{ \pm 0.5}$ |
| e | f | g |  |
| $\phi 23^{ \pm 1}$ | $2.0^{ \pm 0.5}$ | $2.0^{ \pm 0.5}$ |  |

Direction of product insertion

[Packing : 1 000pcs/reel]

## Tape and Reel package

## 2. Wide SMT Gullwing Lead-Form

## Package materials

Carrier tape : A-PET (with anti-static material)
Cover tape : PET (three layer system)
Reel: PS
Carrier tape structure and Dimensions


Dimensions List
(Unit : mm)

| A | B | C | D | E | F | G |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $24.0^{ \pm 0.3}$ | $11.5^{ \pm 0.1}$ | $1.75^{ \pm 0.10}$ | $12.0^{ \pm 0.1}$ | $2.0^{ \pm 0.1}$ | $4.0^{ \pm 0.1}$ | $\phi 1.5_{-0.1}^{+0.1}$ |
| H | I | J | K |  |  |  |
| $12.4^{ \pm 0.1}$ | $0.40^{ \pm 0.05}$ | $4.05^{ \pm 0.10}$ | $10.0^{ \pm 0.1}$ |  |  |  |

Reel structure and Dimensions


| Dimensions List |  | (Unit : mm) |  |
| :---: | :---: | :---: | :---: |
| a | b | c | d |
| $\phi 330$ | $25.5^{ \pm 1.5}$ | $\phi 100^{ \pm 1}$ | $\phi 13.0^{ \pm 0.5}$ |
| e | f | g |  |
| $\phi 23^{ \pm 1}$ | $2.0^{ \pm 0.5}$ | $2.0^{ \pm 0.5}$ |  |

Direction of product insertion

[Packing : 1 000pcs/reel]

## Important Notices

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--- Office automation equipment
--- Telecommunication equipment [terminal]
--- Test and measurement equipment
--- Industrial control
--- Audio visual equipment
--- Consumer electronics
(ii) Measures such as fail-safe function and redundant design should be taken to ensure reliability and safety when SHARP devices are used for or in connection
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--- Traffic signals
--- Gas leakage sensor breakers
--- Alarm equipment
--- Various safety devices, etc.
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